

Notice of References Cited	Application/Control No. 10/806,227		Applicant(s)/Patent Under Reexamination TIEN, JASON	
	Examiner Iriana Cruz		Art Unit 2609	Page 1 of 1

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*	B	US-6,172,704	01-2001	Kunishige, Keiji	348/96
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NON-PATENT DOCUMENTS

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